

NPI solutions for electronics

Test engineering solutions for PCB Assembly: accelerated test and inspection

SIMATIC IT Unicam Test Expert

Answers for industry.

SIEMENS

Simatic IT for the electronics industry

Simatic IT Unicam Test Expert fully automates test engineering associated with new product introduction processes for PCB Assembly. With more than 1,500 customer sites, Simatic IT Unicam Test Expert is the most widely used solution of its kind for electronics manufacturers.

Simatic IT Unicam Test Expert is a fully integrated solution that allows electronics manufacturers to go from design to test and inspection in a matter of minutes or hours rather than days.

With its fast, user-programmable, nail/probe selection routine and complementary interactive tools, Simatic IT Unicam Test Expert offers complete flexibility and control during fixture design and flying probe selection.

Simatic IT Unicam Test Expert eases access on dense boards with a global probe offset tool. A nail advisor evaluates fixture cost. Automatic calibration box generation and interactive definition accelerate calibration box placement for optical inspection applications.

Simatic IT Unicam Test Expert reduces cycle times on variants of the same board by managing attributes such as device types, values and tolerances as well as package and pad sizes/shapes. Simatic IT Unicam Test Expert automatically generates recipes for more than 75 ICT, flying probe testers, x-ray and AOI machines.

Process-oriented flowchart guides the automated process

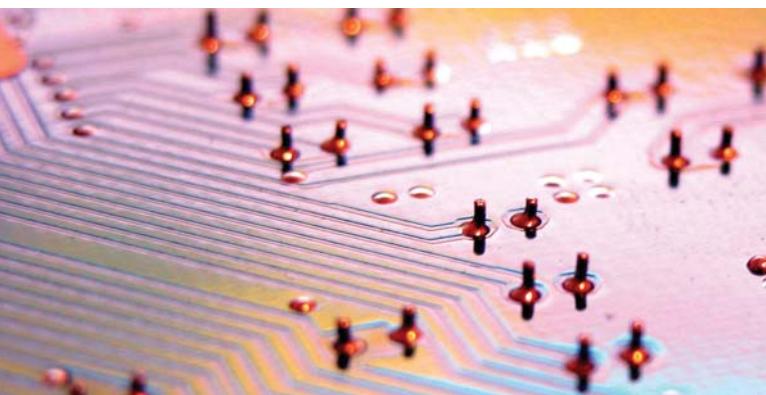
The flowchart contains all of the steps in the test inspection process, guiding the user from CAD and BOM input, through probe selection and fixture design, to program generation. This ensures that the same, tested procedures will be used repeatedly to reduce errors.

Project manager

Simatic IT Unicam Test Expert divides the project into hierarchically project, product (family) and job (revision). After selecting the purpose of the project (for example, design for testability, full test or inspection) and specifying an in-house or custom library, Simatic IT Unicam Test Expert graphically displays the differences between the revisions of a product.

Features

- Support of CAD from all major platforms, including nets, vias and test points etc.
- Program generation for 75 different ATE platforms including the leading ICT, AOI, Flying Probe and x-ray machines
- Fully automated design for test offering design and engineering teams upfront accessibility reports on test coverage limitations
- Automated fixture design including user-definable rules for probe and nail selection including panelized boards
- Library editor for modifying attributes for individual electrical devices, physical outlines and parts allowing better accuracy on global probe offsets
- Interactive viewer to cross reference schematic-to-board layout



Board accessibility report

Simatic IT Unicam Test Expert's recovery of the full CAD data allows probes to be selected and the fixture designed before a single bare board has been manufactured.

Simatic IT Unicam Test Expert generates a complete, easy to follow accessibility report that can be fed back to design if modifications are required. The report states if no or not enough nail/probe locations were found on each net and indicates why.

Examples include: nodes on the net were inaccessible due to solder mask; there are insufficient probe/probe or probe/part body or probe/board edge clearances; the tester channel limit has been exceeded.

Graphics links and search engines

An automatic link between the accessibility report and the CAD graphics makes it easy to view problem nets and decide on corrective action. Search engines for parts, nails, nail shapes, nets and pins facilitate the checking of nail/probe selections.

Interactive nail/probe editor

When there are special requirements, an interactive editor can be used to add, move and delete nails/probes. An automatic checking routine can be enabled to verify that changes made using the editor conform to the rules in the current test profile. Any nails/probes that do not conform to the rules are flagged graphically.

Schematic viewer

Schematic diagrams are recovered in HP-GL/2 format for use during repair and diagnostics applications.

Nail retro-annotation

Simatic IT Unicam Test Expert graphically displays nails on the PCB layout and allows you to annotate nails back to the schematic. This is helpful for repair because it allows cross-probing of nails between the PCB layout and the schematic viewer.

Simatic IT Unicam-View Expert for Test

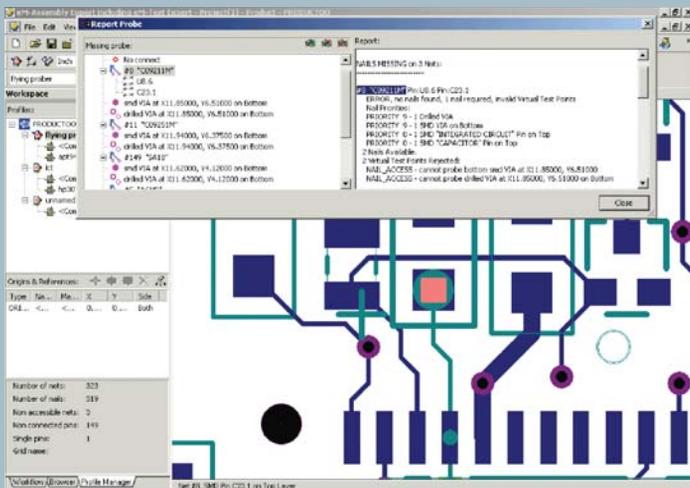
Using the Simatic IT Unicam-View Expert for Test software, electronics manufacturing personnel and customers of electronics manufacturers can view boards in production. In particular, customers can check that board design data has been correctly received and processed by the manufacturer before boards go into production. Customers can search the database for parts, nets and nails.

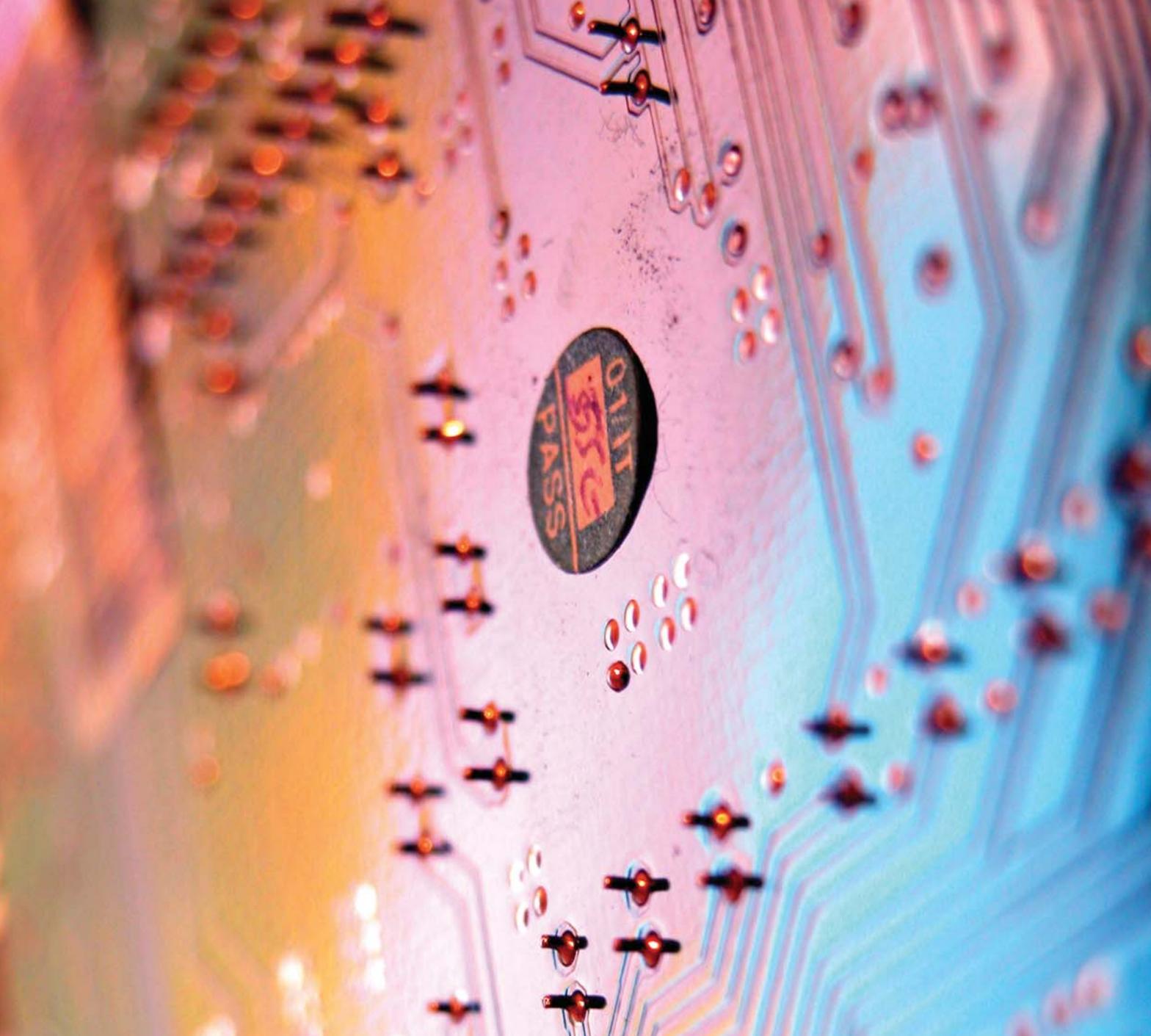
Simatic IT for Electronics

Simatic IT for Electronics is an end-to-end collaborative solution that enables the planning, design, analysis, optimization and operation of manufacturing processes – letting users create and share manufacturing information across the enterprise and throughout the supply chain.

Siemens solutions help manufacturers implement effective manufacturing strategies – from sharing product and process designs, to joint process planning and engineering by teams in distributed locations – helping planners to make decisions such as where, how and with what resources to manufacture products.

Leading manufacturers around the world are adopting Siemens solutions to expand revenue potential by accelerating product introductions, reducing costs, shortening time-to-volume and optimizing production execution.





Benefits:

- CAD/BOM recovery up to 60X faster
- Test fixture design and setup 20X faster
- Design for test (DFT) allows upfront debugging of marginal design errors resulting in better process quality
- Test accessibility reports in minutes from job import
- Re-use of test methodologies for project variants reduces time and costs associated with fixture design and equipment programming
- Program mixed test and inspection equipment and technologies on a single platform
- High flexibility in selecting probe strategies allows results in more economical test fixtures

Get more information

www.siemens.com/mes-simaticit

Accelonix Ltd
Unit2, McClintock Building
Granta Park, Great Abington
Cambridge, CB23 6GP
Tel: 01223 659 956
Email: sales@accelonix.co.uk

www.siemens.com/mes-simaticit

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